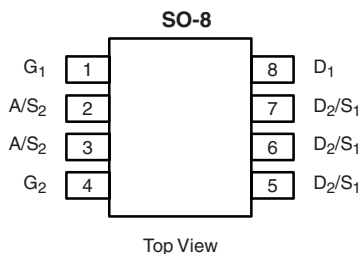


Dual N-Channel 30-V (D-S) MOSFET with Schottky Diode

PRODUCT SUMMARY				
	V _{DS} (V)	R _{DS(on)} (Ω)	I _D (A)	Q _g (Typ.)
Channel-1	30	0.0185 at V _{GS} = 10 V	6.8	7.8
		0.0225 at V _{GS} = 4.5 V	6.0	
Channel-2		0.0115 at V _{GS} = 10 V	11.4	11.6
		0.016 at V _{GS} = 4.5 V	9.5	

SCHOTTKY PRODUCT SUMMARY		
V _{DS} (V)	V _{SD} (V) Diode Forward Voltage	I _F (A)
30	0.50 V at 1.0 A	2.0



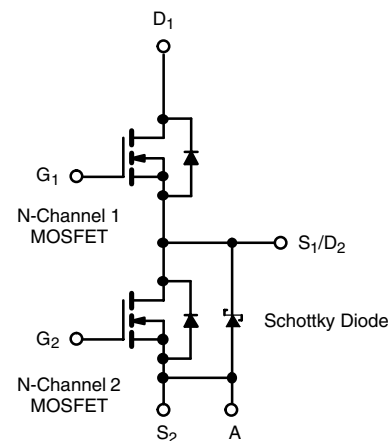
Ordering Information: Si4816BDY-T1-E3 (Lead (Pb)-free)
Si4816BDY-T1-GE3 (Lead (Pb)-free and Halogen-free)

FEATURES

- Halogen-free According to IEC 61249-2-21 Available
- LITTLE FOOT® Plus Power MOSFET
- 100 % R_g Tested



RoHS
COMPLIANT
HALOGEN
FREE
Available



ABSOLUTE MAXIMUM RATINGS T _A = 25 °C, unless otherwise noted								
Parameter		Symbol	Channel-1		Channel-2		Unit	
			10 s	Steady State	10 s	Steady State		
Drain-Source Voltage		V _{DS}	30				V	
Gate-Source Voltage		V _{GS}	20					
Continuous Drain Current (T _J = 150 °C) ^a	T _A = 25 °C	I _D	6.8	5.8	11.4	8.2	A	
	T _A = 70 °C		5.5	4.6	9.0	6.5		
Pulsed Drain Current		I _{DM}	30		40			mJ
Continuous Source Current (Diode Conduction) ^a		I _S	1	0.9	2.2	1.15		
Single Pulse Avalanche Current	L = 0.1 mH	I _{AS}	10		20			
Avalanche Energy		E _{AS}	5		20			
Maximum Power Dissipation ^a	T _A = 25 °C	P _D	1.4	1.0	2.4	1.25	W	
	T _A = 70 °C		0.9	0.64	1.5	0.8		
Operating Junction and Storage Temperature Range		T _J , T _{stg}	- 55 to 150				°C	

THERMAL RESISTANCE RATINGS									
Parameter		Symbol	Channel-1		Channel-2		Schottky		Unit
			Typ.	Max.	Typ.	Max.	Typ.	Max.	
Maximum Junction-to-Ambient ^a	t ≤ 10 s	R _{thJA}	72	90	43	53	48	60	°C/W
	Steady State		100	125	82	100	80	100	
Maximum Junction-to-Foot (Drain)	Steady State	R _{thJF}	51	63	25	30	28	35	

Notes:

a. Surface Mounted on 1" x 1" FR4 board.

MOSFET SPECIFICATIONS T _J = 25 °C, unless otherwise noted							
Parameter	Symbol	Test Conditions		Min.	Typ. ^a	Max.	Unit
Static							
Gate Threshold Voltage	V _{GS(th)}	V _{DS} = V _{GS} , I _D = 250 μA	Ch-1	1.0		3.0	V
			Ch-2	1.0		3.0	
Gate-Body Leakage	I _{GSS}	V _{DS} = 0 V, V _{GS} = 20 V	Ch-1			100	nA
			Ch-2			100	
Zero Gate Voltage Drain Current	I _{DSS}	V _{DS} = 30 V, V _{GS} = 0 V	Ch-1			1	μA
			Ch-2			100	
		V _{DS} = 30 V, V _{GS} = 0 V, T _J = 85 °C	Ch-1			15	
			Ch-2			2000	
On-State Drain Current ^b	I _{D(on)}	V _{DS} = 5 V, V _{GS} = 10 V	Ch-1	20			A
			Ch-2	30			
Drain-Source On-State Resistance ^b	R _{DS(on)}	V _{GS} = 10 V, I _D = 6.8 A	Ch-1		0.0155	0.0185	Ω
		V _{GS} = 10 V, I _D = 11.4 A	Ch-2		0.0093	0.0115	
		V _{GS} = 4.5 V, I _D = 6.0 A	Ch-1		0.0185	0.0225	
		V _{GS} = 4.5 V, I _D = 9.5 A	Ch-2		0.013	0.016	
Forward Transconductance ^b	g _{fs}	V _{DS} = 15 V, I _D = 6.8 A	Ch-1		30		S
		V _{DS} = 15 V, I _D = 11.4 A	Ch-2		31		
Diode Forward Voltage ^b	V _{SD}	I _S = 1 A, V _{GS} = 0 V	Ch-1		0.73	1.1	V
		I _S = 1 A, V _{GS} = 0 V	Ch-2		0.47	0.5	
Dynamic ^a							
Total Gate Charge	Q _g	Channel-1 V _{DS} = 15 V, V _{GS} = 5 V, I _D = 6.8 A	Ch-1		7.8	10	nC
			Ch-2		11.6	18	
Gate-Source Charge	Q _{gs}	Channel-2 V _{DS} = 15 V, V _{GS} = 5 V, I _D = - 11.4 A	Ch-1		2.9		
			Ch-2		4.8		
Gate-Drain Charge	Q _{gd}		Ch-1		2.3		
			Ch-2		3.7		
Gate Resistance	R _g		Ch-1	1.5	3.0	4.5	Ω
			Ch-2	0.9	1.8	2.7	
Turn-On Delay Time	t _{d(on)}	Channel-1 V _{DD} = 15 V, R _L = 15 Ω I _D ≅ 1 A, V _{GEN} = 10 V, R _g = 6 Ω	Ch-1		11	17	ns
Rise Time	t _r		Ch-2		13	20	
			Ch-1		9	15	
Turn-Off Delay Time	t _{d(off)}		Ch-2		9	15	
		Channel-2 V _{DD} = 15 V, R _L = 15 Ω I _D ≅ 1 A, V _{GEN} = 10 V, R _g = 6 Ω	Ch-1		24	40	
Fall Time	t _f	Ch-2		31	50		
		Ch-1		9	15		
Source-Drain Reverse Recovery Time	t _{rr}	I _F = 1.3 A, dI/dt = 100 A/μs	Ch-1		20	35	
		I _F = 2.2 A, dI/dt = 100 μA/μs	Ch-2		25	40	

Notes:

a. Guaranteed by design, not subject to production testing.

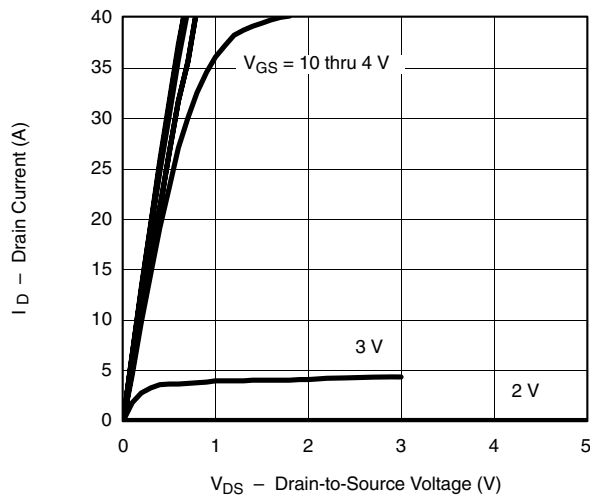
b. Pulse test; pulse width $\leq 300\ \mu\text{s}$, duty cycle $\leq 2\%$.



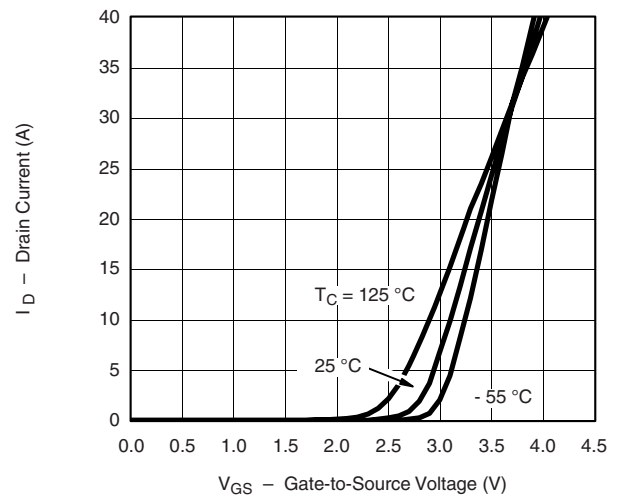
SCHOTTKY SPECIFICATIONS $T_J = 25^\circ\text{C}$, unless otherwise noted						
Parameter	Symbol	Test Conditions	Min.	Typ.	Max.	Unit
Forward Voltage Drop	V_F	$I_F = 1.0\text{ A}$		0.47	0.50	V
		$I_F = 1.0\text{ A}, T_J = 125^\circ\text{C}$		0.36	0.42	
Maximum Reverse Leakage Current	I_{rm}	$V_R = 30\text{ V}$		0.004	0.100	mA
		$V_R = 30\text{ V}, T_J = 100^\circ\text{C}$		0.7	10	
		$V_R = -30\text{ V}, T_J = 125^\circ\text{C}$		3.0	20	
Junction Capacitance	C_T	$V_R = 10\text{ V}$		50		pF

Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated in the operational sections of the specifications is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.

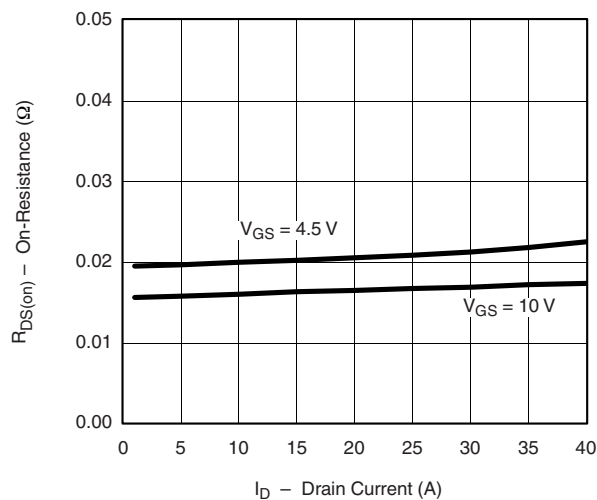
CHANNEL-1 TYPICAL CHARACTERISTICS 25°C , unless otherwise noted



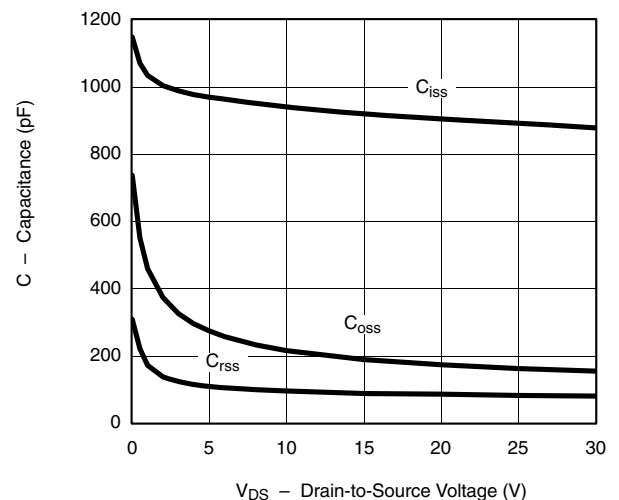
Output Characteristics



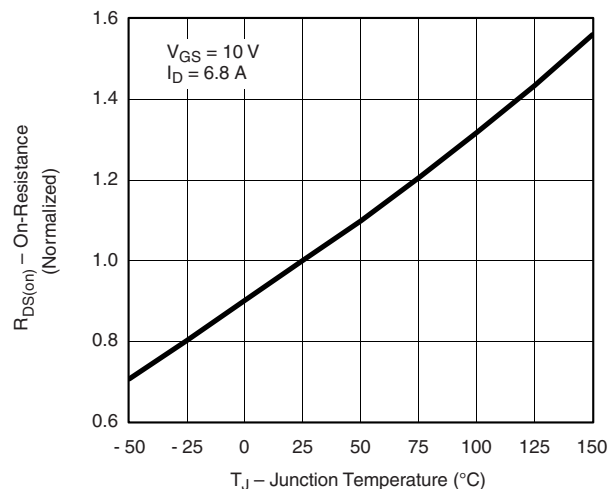
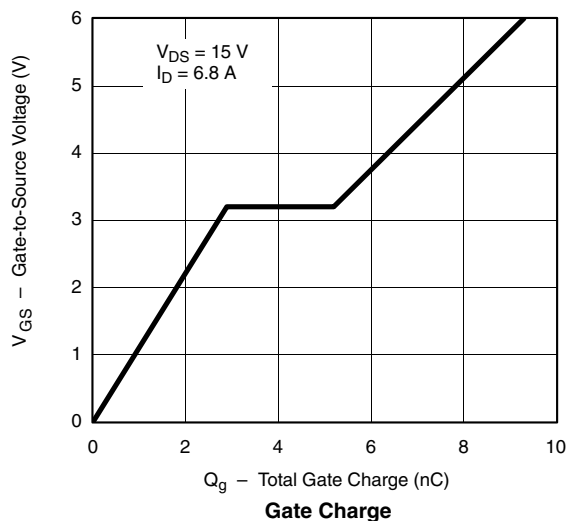
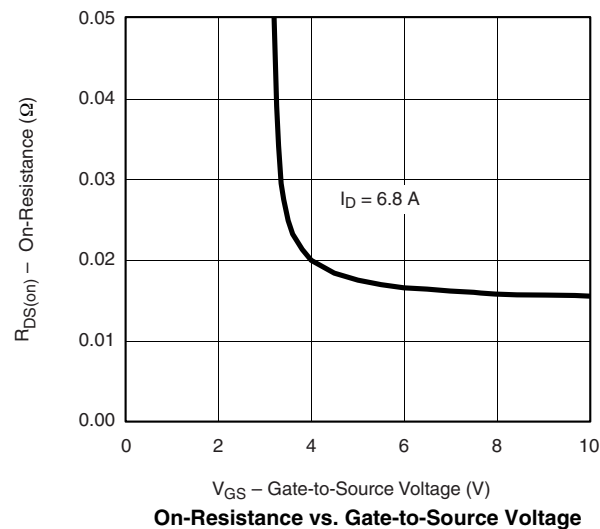
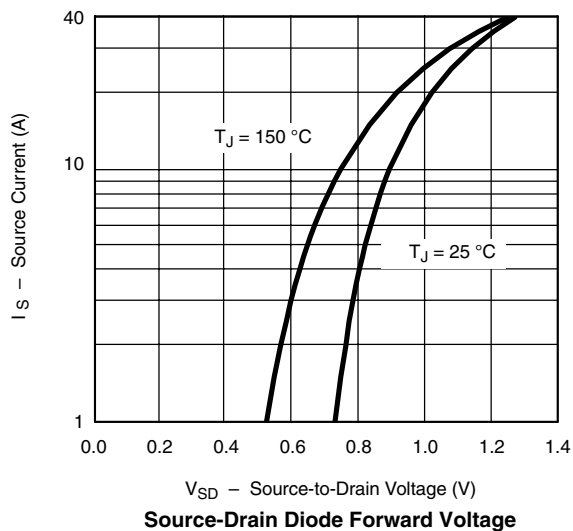
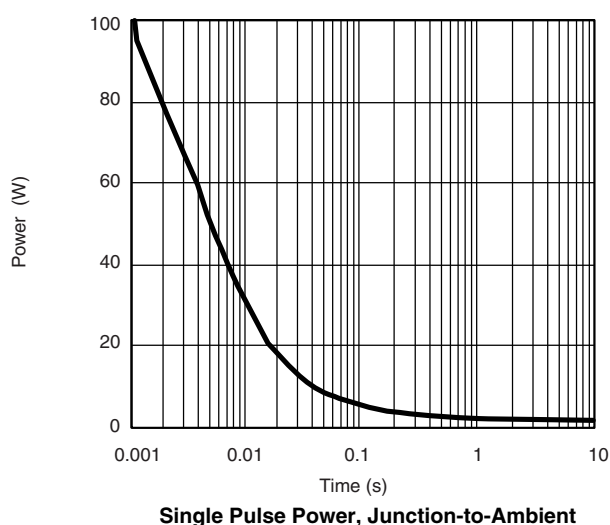
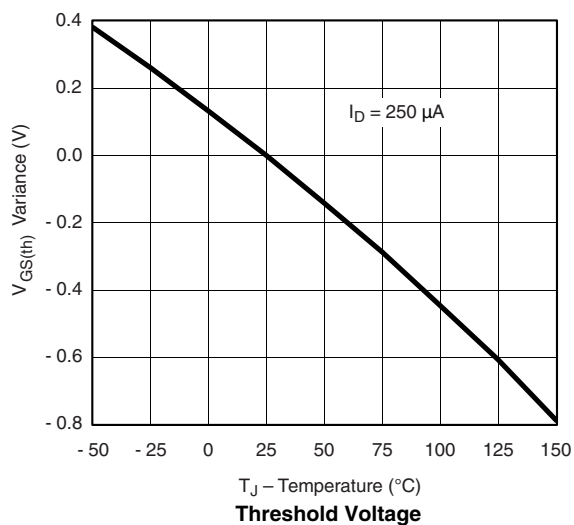
Transfer Characteristics



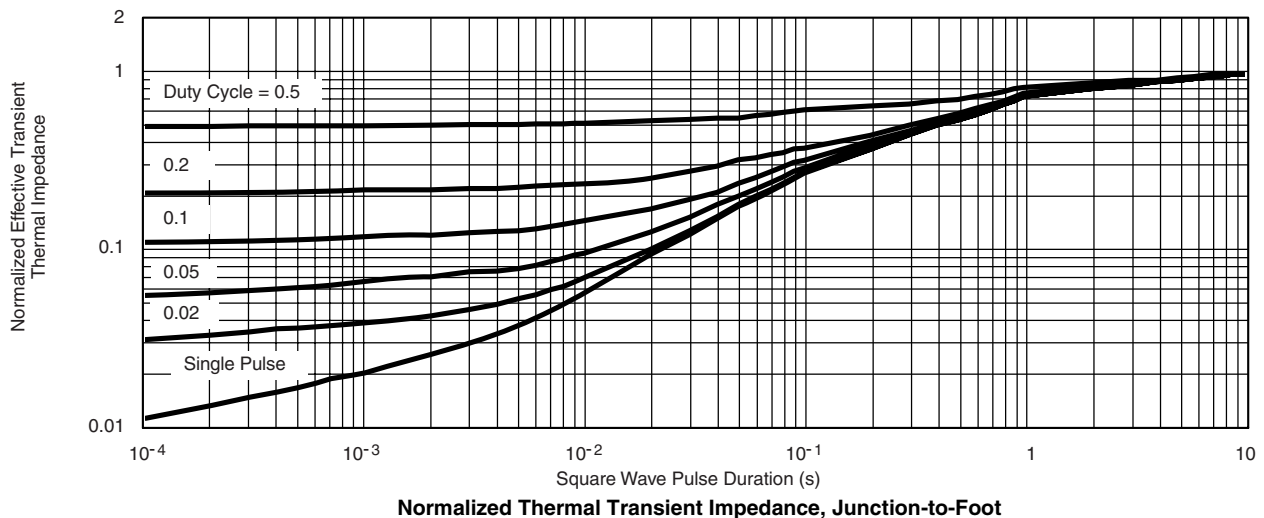
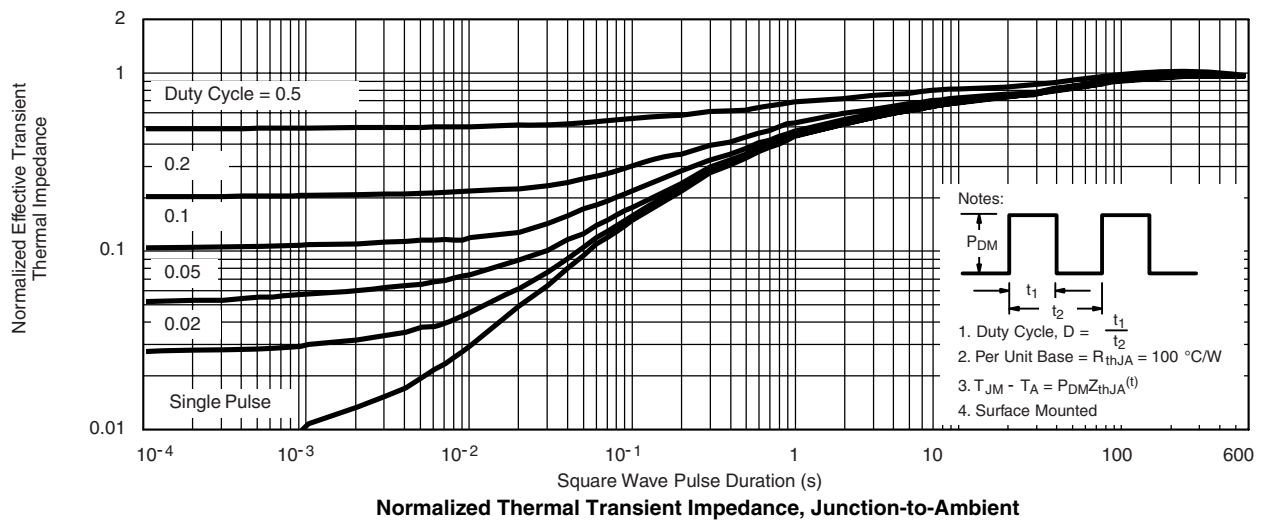
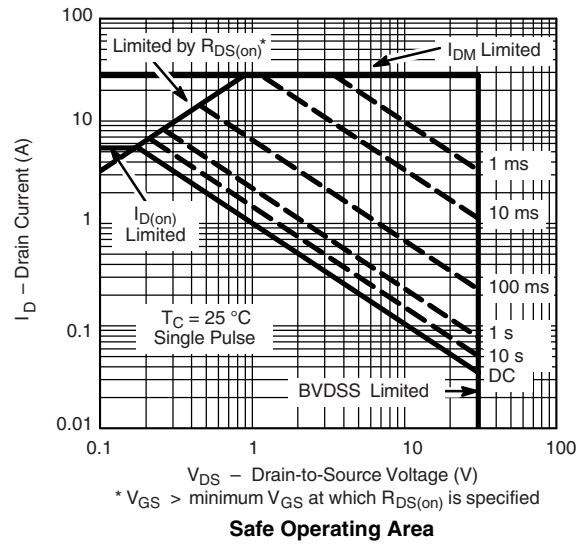
On-Resistance vs. Drain Current

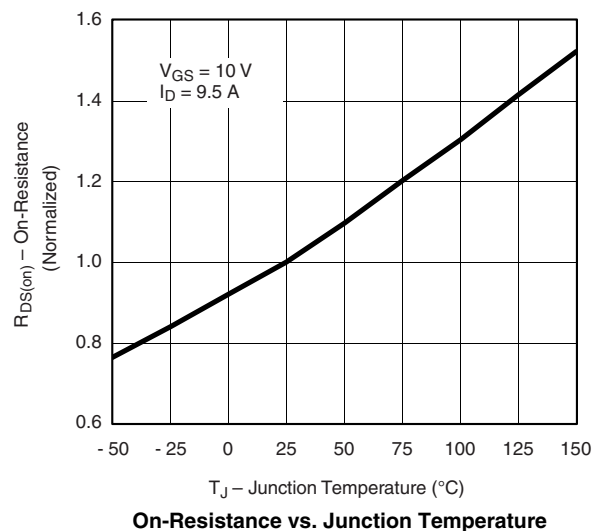
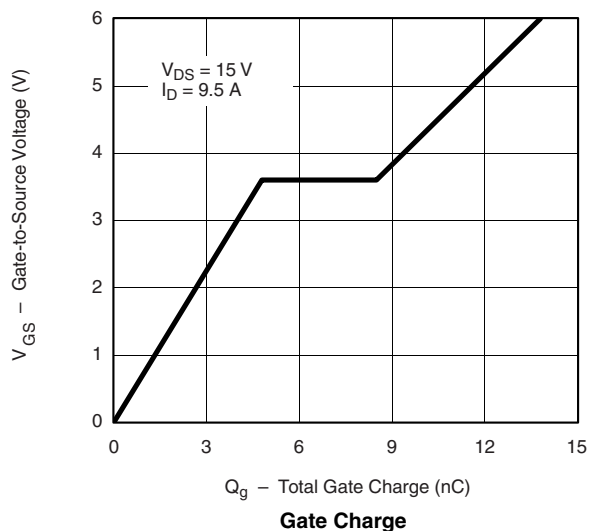
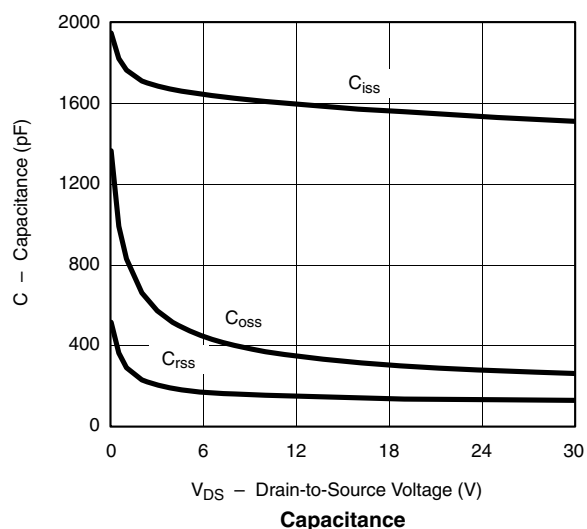
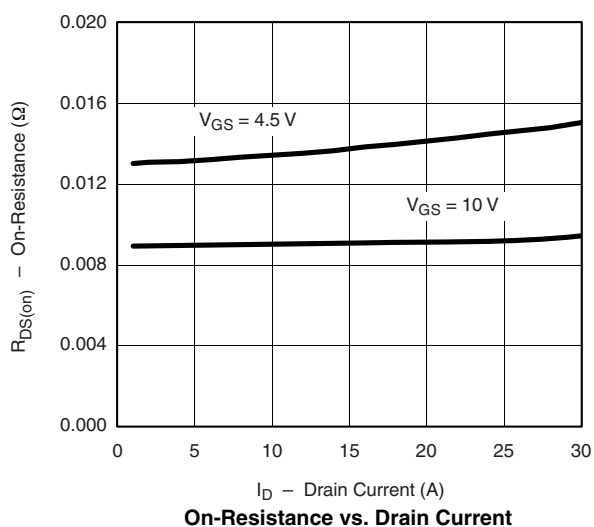
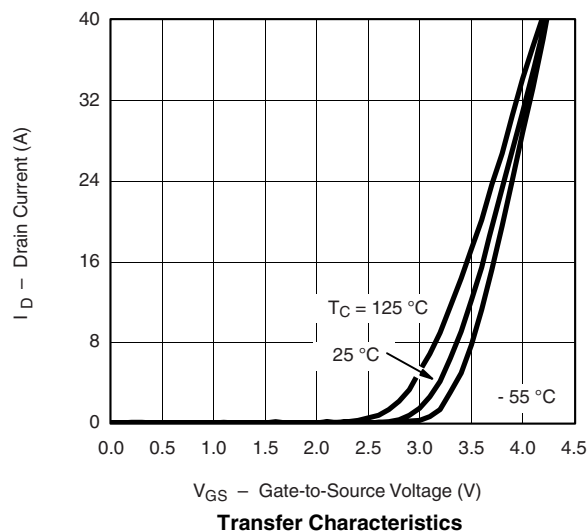
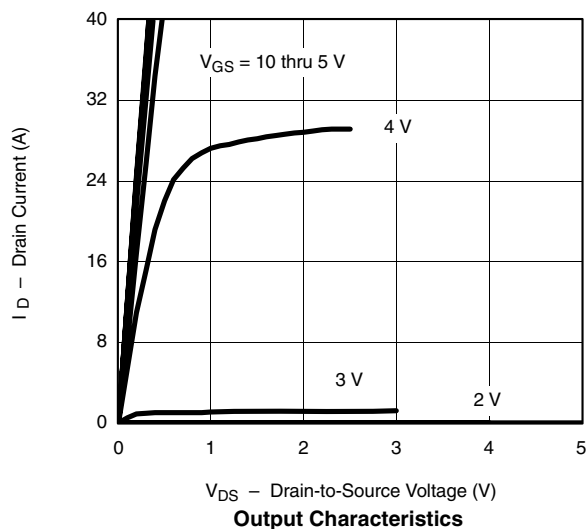


Capacitance

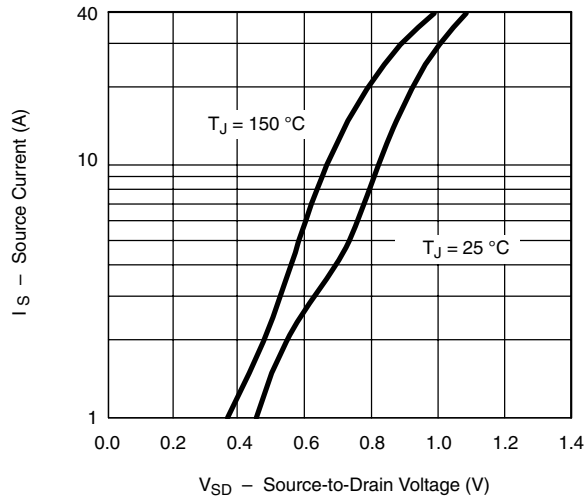
CHANNEL-1 TYPICAL CHARACTERISTICS 25 °C, unless otherwise noted**On-Resistance vs. Junction Temperature****On-Resistance vs. Gate-to-Source Voltage**

CHANNEL-1 TYPICAL CHARACTERISTICS 25 °C, unless otherwise noted

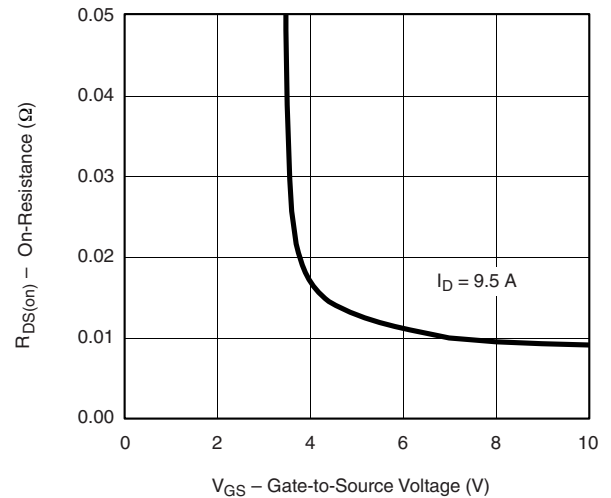


CHANNEL-2 TYPICAL CHARACTERISTICS 25 °C, unless otherwise noted

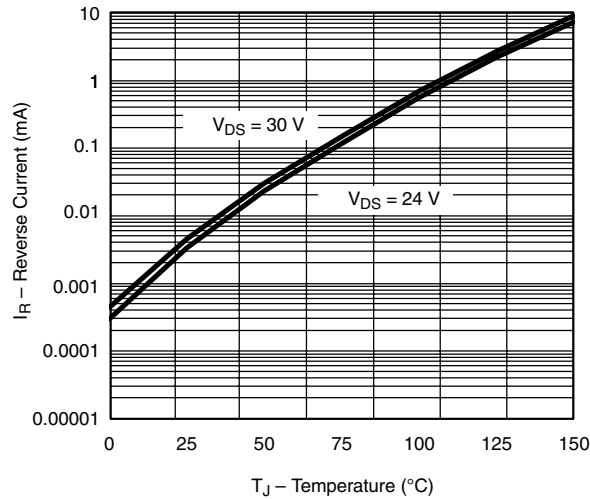
CHANNEL-2 TYPICAL CHARACTERISTICS 25 °C, unless otherwise noted



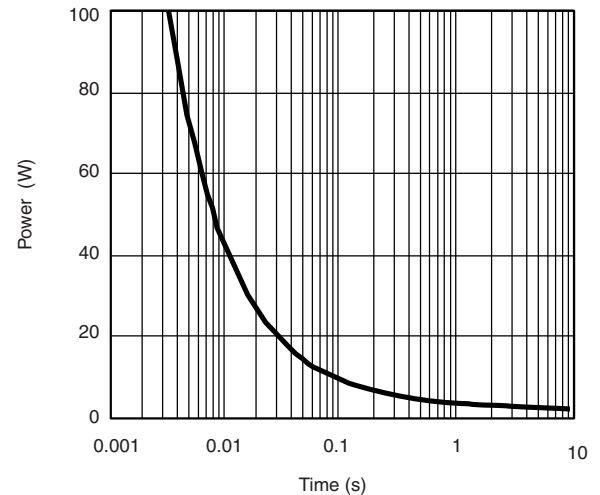
Source-Drain Diode Forward Voltage



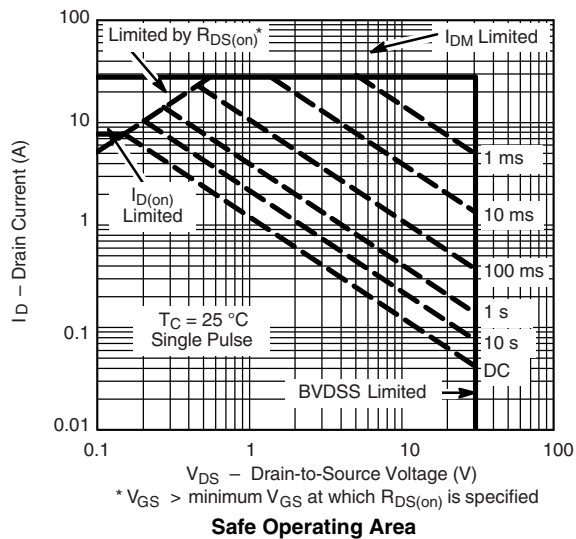
On-Resistance vs. Gate-to-Source Voltage



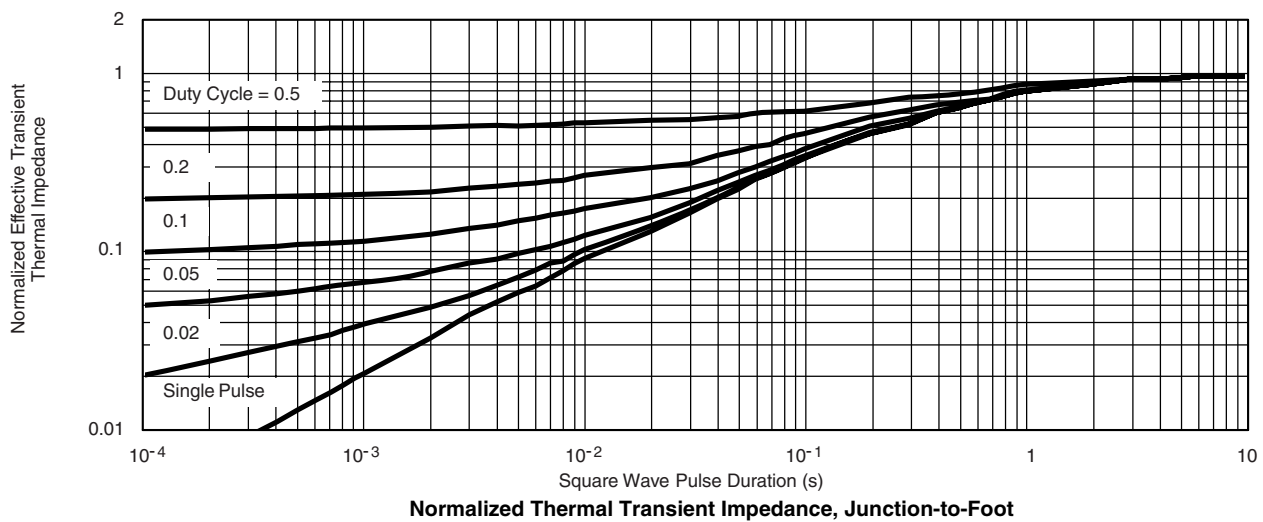
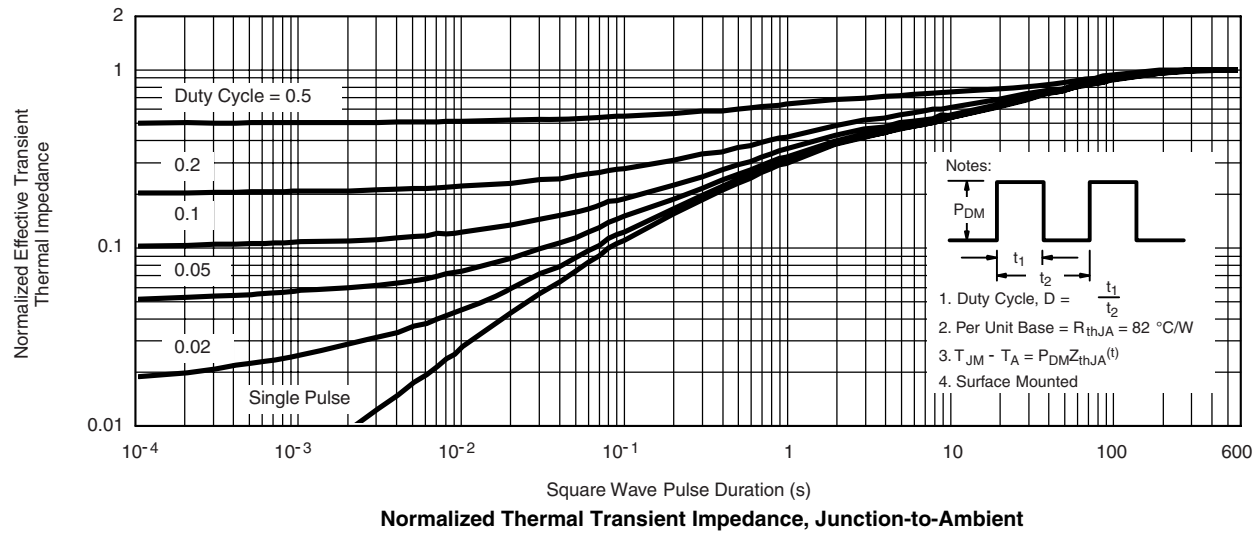
Reverse Current vs. Junction Temperature



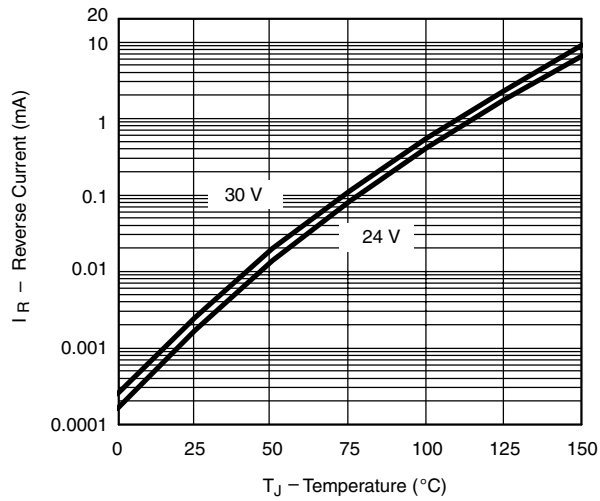
Single Pulse Power, Junction-to-Ambient



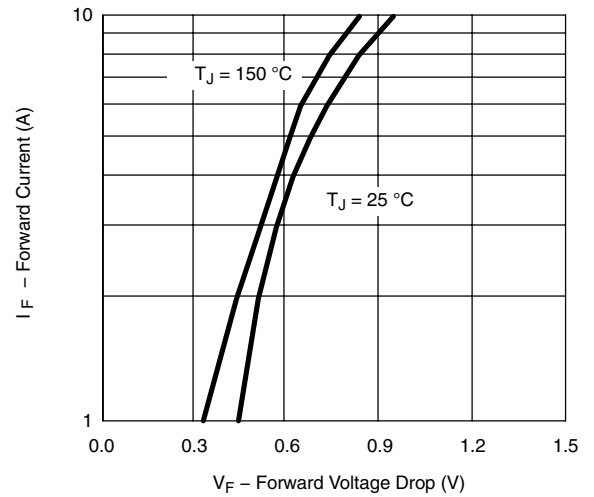
* $V_{GS} >$ minimum V_{GS} at which $R_{DS(on)}$ is specified

CHANNEL-2 TYPICAL CHARACTERISTICS 25 °C, unless otherwise noted

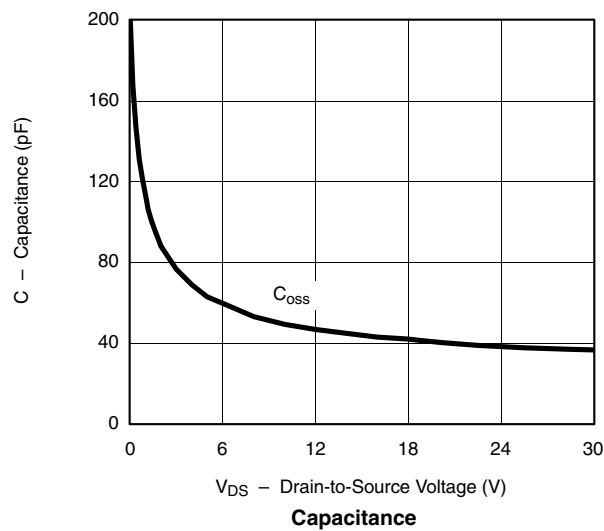
SCHOTTKY TYPICAL CHARACTERISTICS 25 °C, unless otherwise noted



Reverse Current vs. Junction Temperature



Forward Voltage Drop



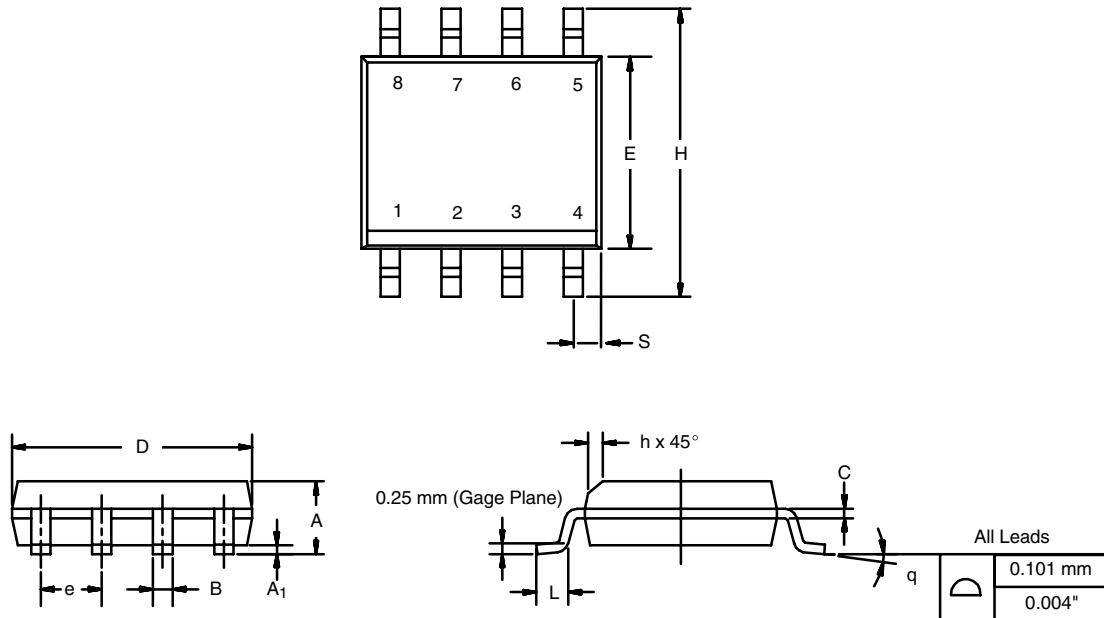
Capacitance

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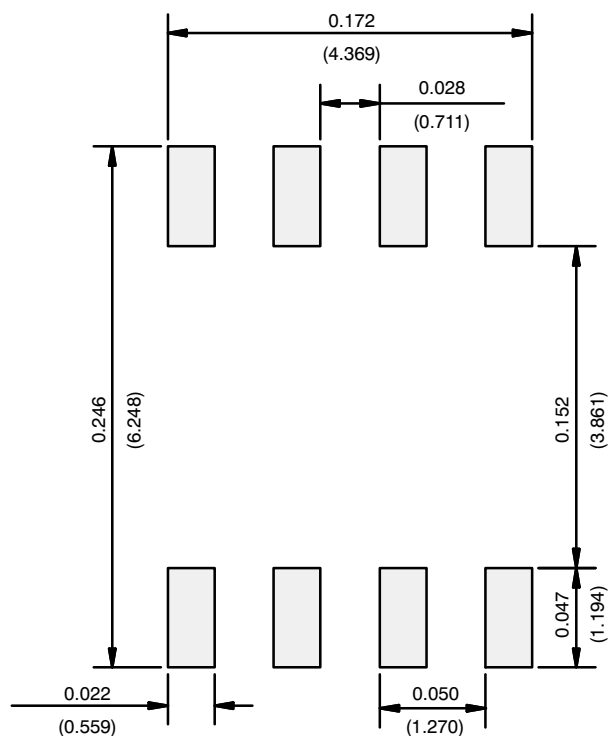
SOIC (NARROW): 8-LEAD

JEDEC Part Number: MS-012



DIM	MILLIMETERS		INCHES	
	Min	Max	Min	Max
A	1.35	1.75	0.053	0.069
A ₁	0.10	0.20	0.004	0.008
B	0.35	0.51	0.014	0.020
C	0.19	0.25	0.0075	0.010
D	4.80	5.00	0.189	0.196
E	3.80	4.00	0.150	0.157
e	1.27 BSC		0.050 BSC	
H	5.80	6.20	0.228	0.244
h	0.25	0.50	0.010	0.020
L	0.50	0.93	0.020	0.037
q	0°	8°	0°	8°
S	0.44	0.64	0.018	0.026
ECN: C-06527-Rev. I, 11-Sep-06				
DWG: 5498				

RECOMMENDED MINIMUM PADS FOR SO-8



Recommended Minimum Pads
Dimensions in Inches/(mm)

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